

MOS FIELD EFFECT TRANSISTOR μ PA2718AGR

SWITCHING P-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA2718AGR is P-Channel MOS Field Effect Transistor designed for power management applications of notebook computers and Lithium-Ion battery protection circuit.

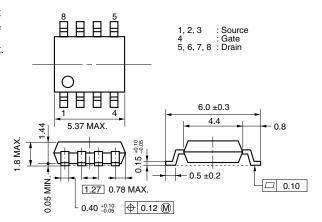
FEATURES

· Low on-state resistance

 $R_{DS(on)1}$ = 9.0 m Ω MAX. (VGS = -10 V, ID = -6.5 A) $R_{DS(on)2}$ = 14.5 m Ω MAX. (VGS = -4.5 V, ID = -6.5 A)

- Low input capacitance
 - Ciss = 2810 pF TYP.
- · Built-in gate protection diode
- Small and surface mount package (Power SOP8)

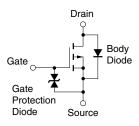
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C, All terminals are connected.)

Drain to Source Voltage (Vss = 0 V)	VDSS	-30	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓20	V
Drain Current (DC)	ID(DC)	∓13	Α
Drain Current (pulse) Note1	I _{D(pulse)}	∓130	Α
Total Power Dissipation Note2	P _{T1}	2	W
Total Power Dissipation Note3	P _{T2}	2	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note4	las	-13	Α
Single Avalanche Energy Note4	Eas	16.9	mJ

EQUIVALENT CIRCUIT



- **Notes 1.** PW \leq 10 μ s, Duty Cycle \leq 1%
 - 2. Mounted on ceramic substrate of 1200 mm² x 2.2 mm
 - 3. Mounted on glass epoxy board of 25.4 mm x 25.4 mm x 0.8 mm, PW = 10 sec
 - **4.** Starting T_{ch} = 25°C, V_{DD} = -15 V, R_G = 25 Ω , L = 100 μ H, V_{GS} = -20 \rightarrow 0 V

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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ELECTRICAL CHARACTERISTICS (TA = 25°C, All terminals are connected.)

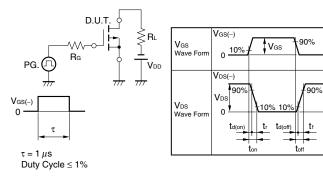
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -30 V, V _{GS} = 0 V			-1	μΑ
Gate Leakage Current	Igss	V _{GS} = ∓20 V, V _{DS} = 0 V			∓10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0		-2.5	V
Forward Transfer Admittance Note	y fs	V _{DS} = -10 V, I _D = -6.5 A	9			S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = -10 V, I _D = -6.5 A		7.2	9.0	mΩ
	RDS(on)2	V _{GS} = -4.5 V, I _D = -6.5 A		9.9	14.5	mΩ
	RDS(on)3	$V_{GS} = -4.0 \text{ V}, I_{D} = -6.5 \text{ A}$		11.8	18.2	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		2810		pF
Output Capacitance	Coss	V _{GS} = 0 V		710		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		460		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = -15 V, I _D = -6.5 A		13		ns
Rise Time	tr	V _{GS} = -10 V		18		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		510		ns
Fall Time	tf			310		ns
Total Gate Charge	QG	V _{DD} = -24 V		67		nC
Gate to Source Charge	QGS	V _{GS} = -10 V		6.5		nC
Gate to Drain Charge	Q _{GD}	I _D = -13 A		19		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 13 A, V _{GS} = 0 V		0.84		V
Reverse Recovery Time	trr	I _F = 13 A, V _{GS} = 0 V		180		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A/μs		14		nC

Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = -20 \rightarrow 0 \text{ V}$ V_{DD} V_{DD}

TEST CIRCUIT 2 SWITCHING TIME

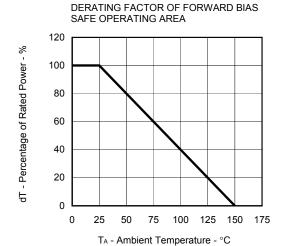


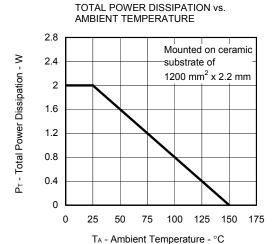
TEST CIRCUIT 3 GATE CHARGE

$$\begin{array}{c|c} D.U.T. & & \\ \hline \\ I_G = -2 \text{ mA} & & \\ \hline \\ PG. & \\ \hline \\ \end{array} \begin{array}{c} PR_L \\ \hline \\ \end{array} \begin{array}{c} V_{DD} \\ \hline \\ \end{array}$$

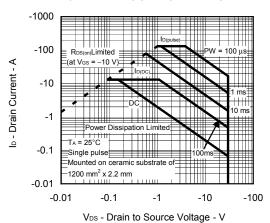
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

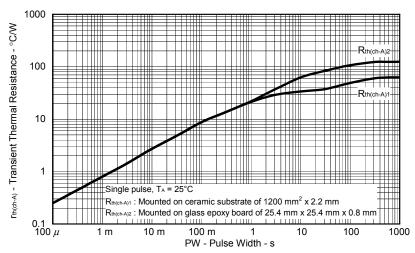




FORWARD BIAS SAFE OPERATING AREA

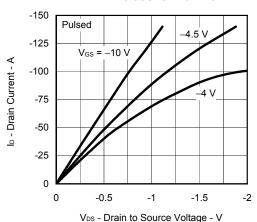


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

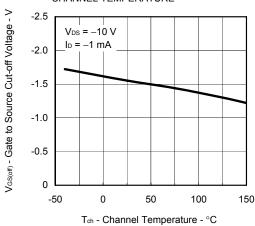


Data Sheet G19280EJ1V0DS 3

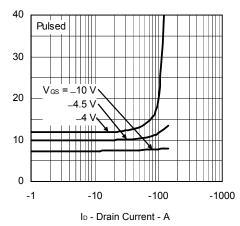
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



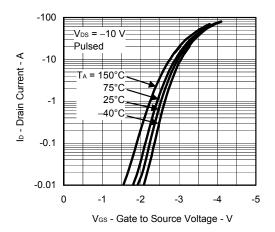
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



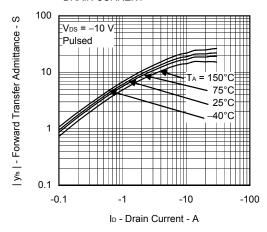
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



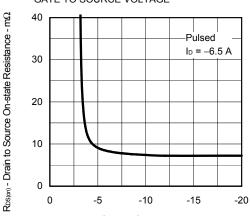
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



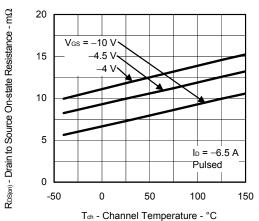
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



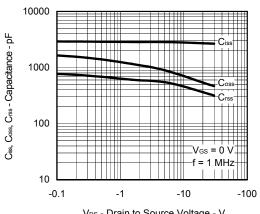
V_{GS} - Gate to Source Voltage - V

Ros(on) - Drain to Source On-state Resistance - mΩ

DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

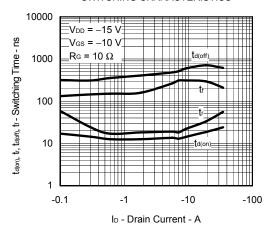


CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

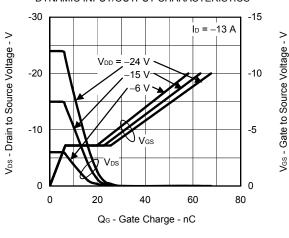


VDS - Drain to Source Voltage - V

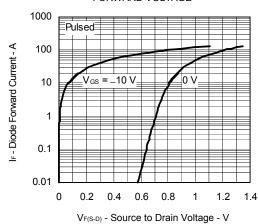
SWITCHING CHARACTERISTICS



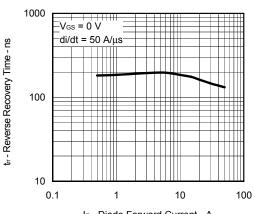
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



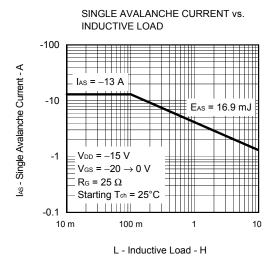
SOURCE TO DRAIN DIODE FORWARD VOLTAGE

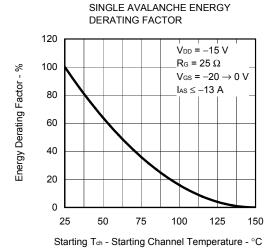


REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



IF - Diode Forward Current - A





ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE
μPA2718AGR-E1-AT Note	Pure Sn (Tin)		Power SOP8
μ PA2718AGR-E2-AT Note		Tape 2500 p/reel	0.08 g TYP.

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

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